

Application/Control No.	Applicant(s)/Patent under Reexamination READHEAD ET AL.	
10/054,365		
Examiner	Art Unit	
Anoop Singh	1632	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST: USPAT, US-PGPUB, EPO, JPO, DERWENT Search report Seperately attached	2/12/2007	AKS
STN, Embase, Medline, Caplus, BiosisSearch report Seperately attached	2/12/2007	AKS
PALMInventor Name Search	2/12/2007	AKS